Power MOSFET

30 V, 9.4 mΩ, 40 A, Single N–Channel, μ 8FL

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- NVTFS4C13NWF Wettable Flanks Product
- NVT Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC–Q101 Qualified and PPAP Capable
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

Symbol Value Unit Parameter Drain-to-Source Voltage VDSS 30 V V Gate-to-Source Voltage V_{GS} ±20 Continuous Drain $T_A = 25^{\circ}C$ 14 А I_D Current R_{0.1A} (Notes 1, 2, 4) $T_A = 100^{\circ}C$ 10 Power Dissipation R_{0JA} $T_A = 25^{\circ}C$ W 3.0 P_D (Note 1, 2, 4) $T_A = 100^{\circ}C$ 1.5 Steady State 40 **Continuous Drain** $T_{\rm C} = 25^{\circ}{\rm C}$ ID Current R_{0JC} (Note 1, $T_{\rm C} = 100^{\circ}{\rm C}$ 28 А 3, 4) Power Dissipation $T_{\rm C} = 25^{\circ}{\rm C}$ PD 26 W R_{0JC} (Note 1, 3, 4) $T_C = 100^{\circ}C$ 13 Pulsed Drain Current 152 Α $T_A = 25^{\circ}C, t_p = 10 \ \mu s$ IDM °C **Operating Junction and Storage Temperature** TJ, -55 to T_{stg} +175 Source Current (Body Diode) IS 24 Α Single Pulse Drain-to-Source Avalanche Energy 10 mJ E_{AS} $(T_J = 25^{\circ}C, I_L = 14 A_{pk}, L = 0.1 \text{ mH})$ Lead Temperature for Soldering Purposes T_L 260 °C (1/8'' from case for 10 s)

MAXIMUM RATINGS (T_{.1} = 25° C unless otherwise stated)

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State (Drain) (Notes 1 and 4)	R_{\thetaJC}	5.8	°C/W
Junction-to-Ambient – Steady State (Notes 1 and 2)	R_{\thetaJA}	50	0/11

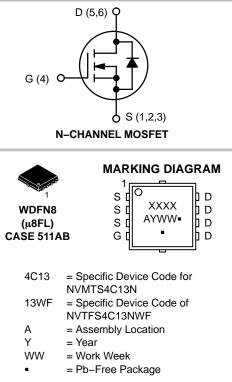
- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface-mounted on FR4 board using a 650 mm² 2 oz. Cu pad.
- 3. Assumes heat-sink sufficiently large to maintain constant case temperature independent of device power.
- 4. Continuous DC current rating. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.



ON Semiconductor®

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V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
30 V	9.4 mΩ @ 10 V	40 A
30 V	14 mΩ @ 4.5 V	40 A



(Note: Microdot may be in either location)

ORDERING INFORMATION

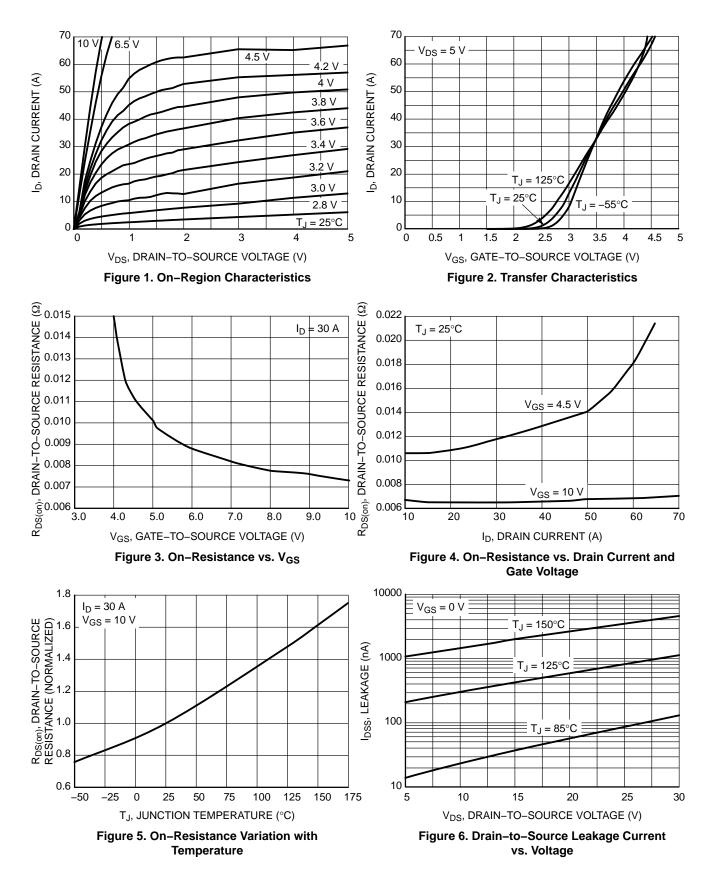
See detailed ordering and shipping information on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS (T_J = 25° C unless otherwise specified)

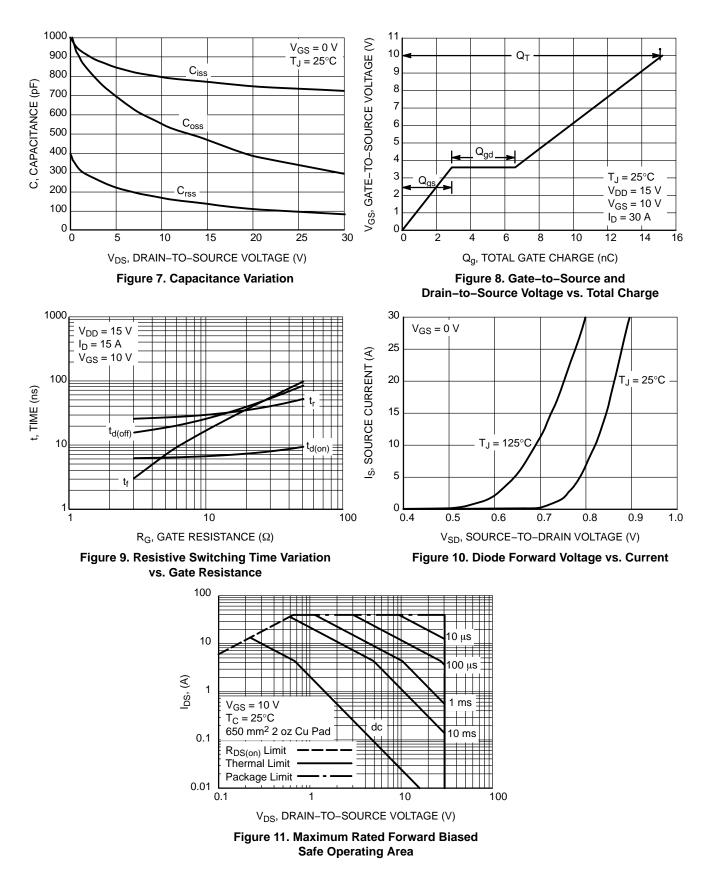
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit	
OFF CHARACTERISTICS							•	
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0 V, I _D = 250 μA		30			V	
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} / T _J				14.9		mV/°C	
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V, V _{DS} = 24 V	$T_J = 25^{\circ}C$ $T_J = 125^{\circ}C$			1.0 10	μΑ	
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 V, V_{GS}$	= ±20 V			±100	nA	
ON CHARACTERISTICS (Note 5)								
Gate Threshold Voltage	V _{GS(TH)}	V _{GS} = V _{DS} , I _D =	= 250 μA	1.3		2.1	V	
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				4.8		mV/°C	
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 30 A		7.5	9.4		
		V _{GS} = 4.5 V	I _D = 12 A		11.2	14	mΩ	
Forward Transconductance	9 _{FS}	V _{DS} = 1.5 V, I _D) = 15 A		40		S	
Gate Resistance	R _G	T _A = 25°	C		1.0		Ω	
CHARGES AND CAPACITANCES								
Input Capacitance	C _{ISS}				770		pF	
Output Capacitance	C _{OSS}	V _{GS} = 0 V, f = 1 MH:	z, V _{DS} = 15 V		443			
Reverse Transfer Capacitance	C _{RSS}				127			
Capacitance Ratio	C _{RSS} /C _{ISS}	V _{GS} = 0 V, V _{DS} = 15 V, f = 1 MHz			0.165			
Total Gate Charge	Q _{G(TOT)}				7.8		-	
Threshold Gate Charge	Q _{G(TH)}				1.4			
Gate-to-Source Charge	Q _{GS}	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V}; I_D = 30 \text{ A}$ $V_{GS} = 10 \text{ V}, V_{DS} = 15 \text{ V}; I_D = 30 \text{ A}$			2.9		nC	
Gate-to-Drain Charge	Q _{GD}				3.7			
Gate Plateau Voltage	V _{GP}				3.6		V	
Total Gate Charge	Q _{G(TOT)}				15.2		nC	
SWITCHING CHARACTERISTICS (Note 6)	· · · · ·							
Turn-On Delay Time	t _{d(ON)}				9		-	
Rise Time	t _r	Vcs = 4.5 V. Vps	s = 15 V.		35			
Turn–Off Delay Time	t _{d(OFF)}	V_{GS} = 4.5 V, V_{DS} = 15 V, I_{D} = 15 A, R_{G} = 3.0 Ω			13		ns	
Fall Time	t _f				5			
Turn-On Delay Time	t _{d(ON)}	V_{GS} = 10 V, V_{DS} = 15 V, I _D = 15 A, R _G = 3.0 Ω			6.0		ns	
Rise Time	tr				26			
Turn–Off Delay Time	t _{d(OFF)}				16			
Fall Time	t _f				3.0			
DRAIN-SOURCE DIODE CHARACTERISTIC	s							
Forward Diode Voltage	V _{SD}	V _{GS} = 0 V,	T _J = 25°C		0.82	1.1		
		$I_{\rm S} = 30 \rm{A}$	T _J = 125°C		0.69	1	V	
Reverse Recovery Time	t _{RR}	V _{GS} = 0 V, dIS/dt = 100 A/µs, I _S = 30 A			23.4			
Charge Time	ta				12.1		ns	
Discharge Time	t _b				11.3		1	
Reverse Recovery Charge	Q _{RR}				9.7		nC	

 $\begin{array}{ll} \text{5. Pulse Test: pulse width} \leq 300 \ \mu\text{s} \text{, duty cycle} \leq 2\%. \\ \text{6. Switching characteristics are independent of operating junction temperatures.} \end{array}$

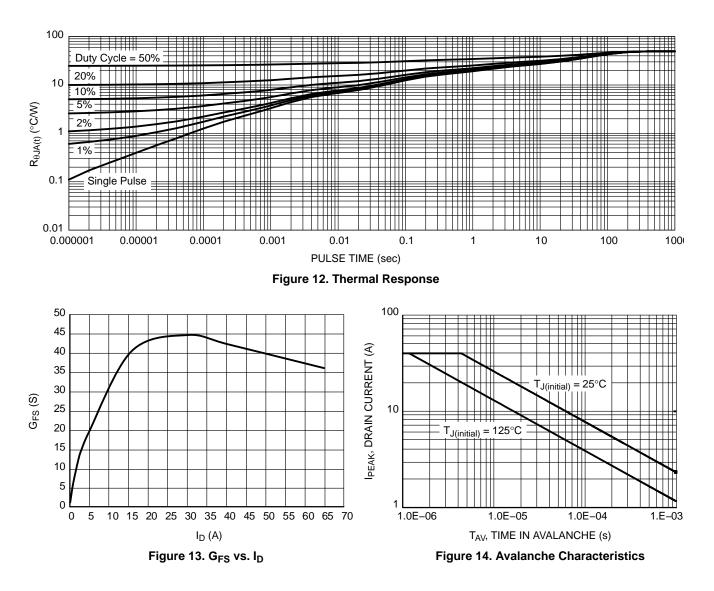
TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS



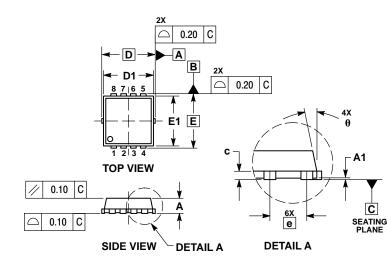
ORDERING INFORMATION

Device	Package	Shipping [†]
NVTFS4C13NTAG	WDFN8 (Pb-Free)	1500 / Tape & Reel
NVTFS4C13NWFTAG	WDFN8 (Pb-Free)	1500 / Tape & Reel
NVTFS4C13NTWG	WDFN8 (Pb-Free)	5000 / Tape & Reel
NVTFS4C13NWFTWG	WDFN8 (Pb-Free)	5000 / Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS

WDFN8 3.3x3.3, 0.65P CASE 511AB ISSUE D

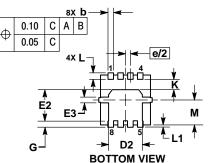


NOTES

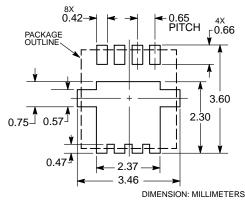
DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
CONTROLLING DIMENSION: MILLIMETERS.

DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH 3. RRS.

	MILLIMETERS			INCHES			
DIM	MIN	NOM	MAX	MIN	NOM	MAX	
Α	0.70	0.75	0.80	0.028	0.030	0.031	
A1	0.00		0.05	0.000		0.002	
b	0.23	0.30	0.40	0.009	0.012	0.016	
С	0.15	0.20	0.25	0.006	0.008	0.010	
D		3.30 BSC			0.130 BSC		
D1	2.95	3.05	3.15	0.116	0.120	0.124	
D2	1.98	2.11	2.24	0.078	0.083	0.088	
E		3.30 BSC		0.130 BSC			
E1	2.95	3.05	3.15	0.116	0.120	0.124	
E2	1.47	1.60	1.73	0.058	0.063	0.068	
E3	0.23	0.30	0.40	0.009	0.012	0.016	
е	0.65 BSC			0.026 BSC			
G	0.30	0.41	0.51	0.012	0.016	0.020	
к	0.65	0.80	0.95	0.026	0.032	0.037	
L	0.30	0.43	0.56	0.012	0.017	0.022	
L1	0.06	0.13	0.20	0.002	0.005	0.008	
М	1.40	1.50	1.60	0.055	0.059	0.063	
θ	0 °		12 °	0 °		12 °	



SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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